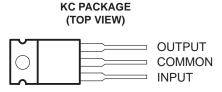
- ±1% Output Tolerance at 25°C
- ±2% Output Tolerance Over Full Operating Range
- Thermal Shutdown

- Internal Short-Circuit Current Limiting
- Pinout Identical to μA7800 Series
- Improved Version of μA7800 Series

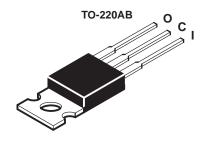
description

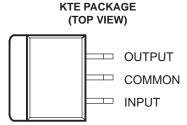
Each fixed-voltage precision regulator in the TL780 series is capable of supplying 1.5 A of load current. A unique temperature-compensation technique, coupled with an internally trimmed band-gap reference, has resulted in improved accuracy when compared to other three-terminal regulators. Advanced layout techniques provide excellent line, load, and thermal regulation. The internal current-limiting and thermal-shutdown features make the devices essentially immune to overload.

The TL780-xxC series regulators are characterized for operation over the virtual junction temperature range of 0°C to 125°C.

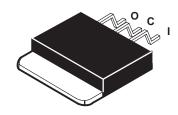


The COMMON terminal is in electrical contact with the mounting base.





The COMMON terminal is in electrical contact with the mounting base.



AVAILABLE OPTIONS

| | | PACKAGEI | DEVICES | CHIP |
|--------------|---------------------------|------------------------------|--------------|-------------|
| TJ | V _O TYP (V) | I LEAT-SINK MOLINTED I 10110 | | FORM (Y) |
| | 5 | TL780-05CKC | TL780-05CKTE | TL780-05Y |
| 0°C to 125°C | 12 | TL780-12CKC | TL780-12CKTE | TL780-12Y |
| | 15 | TL780-15CKC | TL780-15CKTE | TL780-15Y |

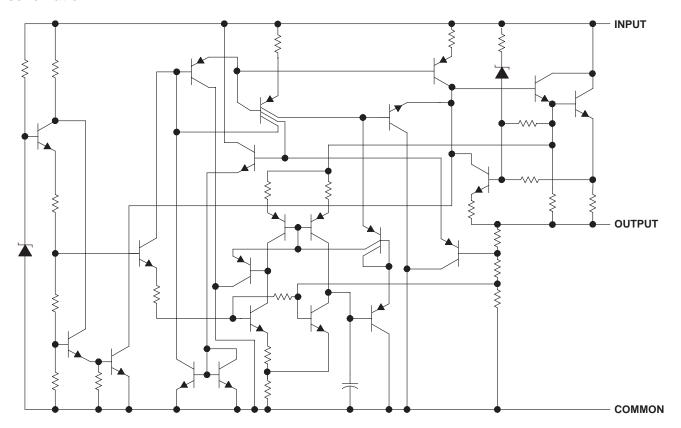
The KTE package is available taped and reeled. Add the suffix R to the device type (e.g., TL780-05CKTER). Chip forms are tested at $25^{\circ}C$.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



schematic



absolute maximum ratings over operating temperature range (unless otherwise noted)†

NOTES: 1. Maximum power dissipation is a function of T_J(max), θ_JA, and T_A. The maximum allowable power dissipation at any allowable ambient temperature is P_D = (T_J(max) – T_A)/θ_JA. Operating at the absolute maximum T_J of 150°C can impact reliability. Due to variations in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions

| | | MIN | MAX | UNIT |
|--|-----------|------|-----|------|
| | TL780-05C | 7 | 25 | |
| Input voltage, V _I | TL780-12C | | 30 | V |
| | TL780-15C | 17.5 | 30 | |
| Output current, IO | | | 1.5 | А |
| Operating virtual junction temperature, TJ | | | 125 | °C |

electrical characteristics at specified virtual junction temperature, V_I = 10 V, I_O = 500 mA (unless otherwise noted)

| DADAMETER | TEST COMPLIANC | _ + | TL780-05C | | | UNIT | |
|---|---|-----------------|-----------|--------|------|--------|--|
| PARAMETER | TEST CONDITIONS | TJ [‡] | MIN | TYP | MAX | UNIT | |
| Output voltage | $I_{O} = 5 \text{ mA to 1 A}, \qquad P \le 15 \text{ W},$ | 25°C | 4.95 | 5 | 5.05 | V | |
| Output voltage | $V_I = 7 \text{ V to } 20 \text{ V}$ | 0°C to 125°C | 4.9 | | 5.1 | V | |
| Input voltage regulation | V _I = 7 V to 25 V | 25°C | | 0.5 | 5 | ., | |
| Input voltage regulation | V _I = 8 V to 12 V | 25.0 | | 0.5 | 5 | mV | |
| Ripple rejection | $V_{I} = 8 \text{ V to } 18 \text{ V}, \qquad f = 120 \text{ Hz}$ | 0°C to 125°C | 70 | 85 | | dB | |
| Output voltage regulation | I _O = 5 mA to 1.5 A | 25°C | | 4 | 25 | mV | |
| | $I_O = 250 \text{ mA to } 750 \text{ mA}$ | 25-0 | | 1.5 | 15 | | |
| Output resistance | f = 1 kHz | 0°C to 125°C | | 0.0035 | | W | |
| Temperature coefficient of output voltage | $I_O = 5 \text{ mA}$ | 0°C to 125°C | | 0.25 | | mV/°C | |
| Output noise voltage | f = 10 Hz to 100 kHz | 25°C | | 75 | | μV | |
| Dropout voltage | I _O = 1 A | 25°C | | 2 | | V | |
| Input bias current | | 25°C | | 5 | 8 | mA | |
| Input high current change | V _I = 7 V to 25 V | 0°C to 125°C | | 0.7 | 1.3 | mA | |
| Input bias-current change | $I_O = 5 \text{ mA to 1 A}$ | 0 0 10 125 0 | | 0.003 | 0.5 | _ '''^ | |
| Short-circuit output current | | 25°C | | 750 | | mA | |
| Peak output current | | 25°C | | 2.2 | | Α | |

[‡] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.22-μF capacitor across the output.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

electrical characteristics at specified virtual junction temperature, V_I = 19 V, I_O = 500 mA (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | _ + | TL780-12C | | | UNIT |
|---|---|-----------------|-----------|------|-------|-------|
| PARAMETER | TEST CONDITIONS | TJ [†] | MIN | TYP | MAX | UNIT |
| Output voltage | $I_0 = 5 \text{ mA to 1 A}, P \le 15 \text{ V}$ | √, 25°C | 11.88 | 12 | 12.12 | V |
| Output voltage | V _I = 14.5 V to 27 V | 0°C to 125°C | 11.76 | | 12.24 | V |
| Input voltage regulation | V _I = 14.5 V to 30 V | 25°C | | 1.2 | 12 | mV |
| Imput voitage regulation | V _I = 16 V to 22 V | 25 C | | 1.2 | 12 | IIIV |
| Ripple rejection | $V_I = 15 \text{ V to } 25 \text{ V}, \qquad f = 120 \text{ H}$ | dz 0°C to 125°C | 65 | 80 | | dB |
| Output voltage regulation | I _O = 5 mA to 1.5 A | 25°C | | 6.5 | 60 | mV |
| Output voltage regulation | I _O = 250 mA to 750 mA | 25 C | | 2.5 | 36 | |
| Output resistance | f = 1 kHz | 0°C to 125°C | 0.0 | 0035 | | W |
| Temperature coefficient of output voltage | $I_O = 5 \text{ mA}$ | 0°C to 125°C | | 0.6 | | mV/°C |
| Output noise voltage | f = 10 Hz to 100 kHz | 25°C | | 180 | | μV |
| Dropout voltage | I _O = 1 A | 25°C | | 2 | | V |
| Input bias current | | 25°C | | 5.5 | 8 | mA |
| Input biog gurrent change | V _I = 14.5 V to 30 V | 0°C to 125°C | | 0.4 | 1.3 | mA |
| Input bias-current change | $I_O = 5$ mA to 1 A | 0 C to 125 C | | 0.03 | 0.5 | IIIA |
| Short-circuit output current | | 25°C | | 350 | | mA |
| Peak output current | | 25°C | | 2.2 | | Α |

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.22-µF capacitor across the output.

electrical characteristics at specified virtual junction temperature, V_I = 23 V, I_O = 500 mA (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | _ + | TL780-15C | | | UNIT | |
|---|--|------------------|-----------|--------|-------|-------|--|
| PARAMETER | TEST CONDITIONS | T _J † | MIN | TYP | MAX | ONIT | |
| Output voltage | $I_{O} = 5 \text{ mA to 1 A}, \qquad P \le 15 \text{ W},$ | 25°C | 14.85 | 15 | 15.15 | V | |
| Output voltage | V _I = 17.5 V to 30 V | 0°C to 125°C | 14.7 | | 15.3 | V | |
| Input voltage regulation | V _I = 17.5 V to 30 V | 25°C | | 1.5 | 15 | >/ | |
| Input voltage regulation | V _I = 20 V to 26 V | 25 C | | 1.5 | 15 | mV | |
| Ripple rejection | $V_I = 18.5 \text{ V to } 28.5 \text{ V}, f = 120 \text{ Hz}$ | 0°C to 125°C | 60 | 75 | | dB | |
| Output voltage regulation | $I_O = 5 \text{ mA to } 1.5 \text{ A}$ | 25°C | | 7 | 75 | mV | |
| | I _O = 250 mA to 750 mA | 25 C | | 2.5 | 45 | | |
| Output resistance | f = 1 kHz | 0°C to 125°C | | 0.0035 | | W | |
| Temperature coefficient of output voltage | $I_O = 5 \text{ mA}$ | 0°C to 125°C | | 0.62 | | mV/°C | |
| Output noise voltage | f = 10 Hz to 100 kHz | 25°C | | 225 | | μV | |
| Dropout voltage | I _O = 1 A | 25°C | | 2 | | V | |
| Input bias current | | 25°C | | 5.5 | 8 | mA | |
| Input bias-current change | V _I = 17.5 V to 30 V | 0°C to 125°C | | 0.4 | 1.3 | mA | |
| Imput bias-current change | $I_O = 5$ mA to 1 A | 0 0 10 123 0 | 0.02 | | 0.5 |] ""A | |
| Short-circuit output current | | 25°C | | 230 | | mA | |
| Peak output current | | 25°C | | 2.2 | | Α | |

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.22-µF capacitor across the output.



electrical characteristics, V_I = 10 V, I_O = 500 mA, T_J = 25°C (unless otherwise noted)

| DADAMETER | | TL780-05Y | | | UNIT |
|------------------------------|--|-----------|-----|-----|------|
| PARAMETER | TEST CONDITIONS† | MIN | TYP | MAX | UNII |
| Output voltage | $I_{O} = 5 \text{ mA to 1 A}, \qquad P \le 15 \text{ W}$ | | 5 | | V |
| Input voltage regulation | V _I = 7 V to 25 V | 0.5 | | \/ | |
| | V _I = 8 V to 12 V | | 0.5 | | mV |
| | I _O = 5 mA to 1.5 A | 4 | | mV | |
| Output voltage regulation | I _O = 250 mA to 750 mA | | 1.5 | | mv |
| Output noise voltage | f = 10 Hz to 100 kHz | | 75 | | μV |
| Dropout voltage | I _O = 1 A | | 2 | | V |
| Input bias current | | | 5 | | mA |
| Short-circuit output current | | | 750 | | mA |
| Peak output current | | | 2.2 | | Α |

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.22-μF capacitor across the output.

electrical characteristics, V_I = 19 V, I_O = 500 mA, T_J = 25°C (unless otherwise noted)

| PARAMETER | TEST SOMBITIONS! | TL780-12Y | | | UNIT |
|------------------------------|--|-----------|-----|-----|------|
| PARAINETER | TEST CONDITIONS† | | TYP | MAX | UNIT |
| Output voltage | $I_O = 5 \text{ mA to 1 A}, \qquad P \le 15 \text{ W}$ | | 12 | | V |
| lanut valta an annulation | $V_{I} = 14.5 \text{ V to } 30 \text{ V}$ | 1.2 | | | mV |
| Input voltage regulation | V _I = 16 V to 22 V | | 1.2 | | IIIV |
| Output with an analysis | $I_{O} = 5 \text{ mA to } 1.5 \text{ A}$ | | 6.5 | | mV |
| Output voltage regulation | $I_O = 250 \text{ mA to } 750 \text{ mA}$ | | 2.5 | | IIIV |
| Output noise voltage | f = 10 Hz to 100 kHz | | 180 | | μV |
| Dropout voltage | I _O = 1 A | | 2 | | V |
| Input bias current | | | 5.5 | | mA |
| Short-circuit output current | | | 350 | | mA |
| Peak output current | | | 2.2 | | А |

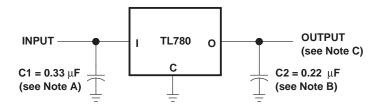
[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.22-µF capacitor across the output.

electrical characteristics, V_I = 23 V, I_O = 500 mA, T_J = 25°C (unless otherwise noted)

| PARAMETER | 7707 00VD/7/0V0† | TL780-15Y | UNIT | |
|------------------------------|--|-------------|-------|--|
| PARAMETER | TEST CONDITIONS† | MIN TYP MAX | UNIT | |
| Output voltage | $I_{O} = 5 \text{ mA to 1 A}, \qquad P \le 15 \text{ W}$ | 15 | V | |
| Input voltage regulation | V _I = 17.5 V to 30 V | 1.5 | mV | |
| Input voltage regulation | V _I = 20 V to 26 V | 1.5 | 111.0 | |
| Output voltage regulation | I _O = 5 mA to 1.5 A | 7 | mV | |
| Output voltage regulation | I _O = 250 mA to 750 mA | 2.5 | 1117 | |
| Output resistance | f = 1 kHz | 0.0035 | W | |
| Output noise voltage | f = 10 Hz to 100 kHz | 225 | μV | |
| Dropout voltage | I _O = 1 A | 2 | V | |
| Input bias current | | 5.5 | mA | |
| Short-circuit output current | | 230 | mA | |
| Peak output current | | 2.2 | Α | |

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.22-μF capacitor across the output.

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C1 is required when the regulator is far from the power-supply filter.

- B. C2 is not required for stability; however, transient response is improved.
- C. Permanent damage can occur when OUTPUT is pulled below ground.

Figure 1. Test Circuit

APPLICATION INFORMATION

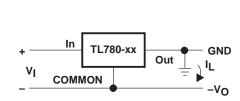


Figure 2. Positive Regulator in Negative Configuration (V_I Must Float)

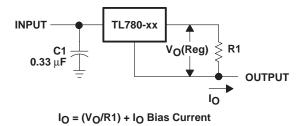


Figure 3. Current Regulator

operation with a load common to a voltage of opposite polarity

In many cases, a regulator powers a load that is not connected to ground but, instead, is connected to a voltage source of opposite polarity (e.g., operational amplifiers, level-shifting circuits, etc.). In these cases, a clamp diode should be connected to the regulator output as shown in Figure 4. This protects the regulator from output polarity reversals during startup and short-circuit operation.

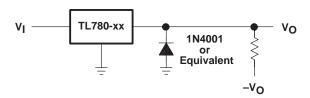


Figure 4. Output Polarity-Reversal-Protection Circuit

reverse-bias protection

Occasionally, the input voltage to the regulator can collapse faster than the output voltage. This, for example, could occur when the input supply is crowbarred during an output overvoltage condition. If the output voltage is greater than approximately 7 V, the emitter-base junction of the series pass element (internal or external) could break down and be damaged. To prevent this, a diode shunt can be employed, as shown in Figure 5.

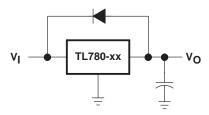
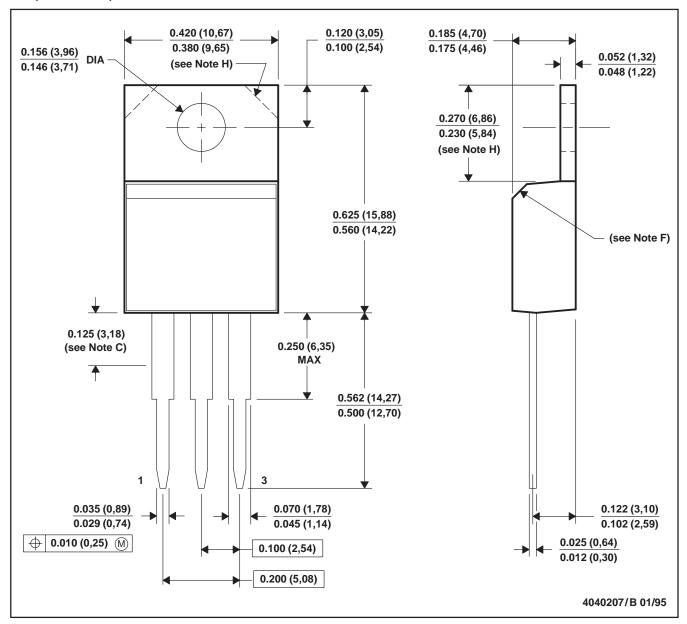


Figure 5. Reverse-Bias-Protection Circuit

KC (R-PSFM-T3)

PLASTIC FLANGE-MOUNT PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Lead dimensions are not controlled within this area.
- D. All lead dimensions apply before solder dip.
- E. The center lead is in electrical contact with the mounting tab.
- F. The chamfer is optional.
- G. Falls within JEDEC TO-220AB
- H. Tab contour optional within these dimensions

